

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. .... 10/756,621  
Filing Date ..... January 12, 2004  
Inventor ..... Cem Basceri et al.  
Assignee ..... Micron Technology, Inc.  
Priority Group Art Unit ..... 2831  
Examiner ..... Unknown  
Attorney Docket No. .... MI22-2466  
Title: Methods of Forming Capacitor Constructions

**RECEIVED**  
**CENTRAL FAX CENTER**

MAR 26 2004

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**OFFICIAL****CERTIFICATE OF FACSIMILE TRANSMISSION UNDER 37 CFR § 1.8**

I hereby certify that the following papers are being facsimile transmitted to the Patent and Trademark Office at (703) 872-9306 on the date shown below:

1. Certificate of Facsimile Transmission
2. Information Disclosure Statement w/PTO-1449

Dated: March 26, 2004By: Jaime White

Jaime White

Telephone No.

(509) 624-4276

Facsimile No.

(509) 838-3424

NUMBER OF PAGES IN FACSIMILE: 4**FEE DEFICIENCY**

Although it is believed that no fees are due, the Commissioner is hereby authorized to charge any fees under 37 C.F.R. 1.16 and 1.17 which may be required by this paper to Deposit Account No. 23-0925.

Dated: 3/26/04By: David G. Latwesen

David G. Latwesen, Ph.D.

Reg. No. 38,533

**RECEIVED  
CENTRAL FAX CENTER**

MAR 26 2004

Inventor: Cem Basceri et al.

Title: Methods of Forming Capacitor Constructions

Assignee: Micron Technology, Inc.

**OFFICIAL****INFORMATION DISCLOSURE STATEMENT****References – See Attached Form PTO-1449**

The attached form PTO-1449 is submitted in compliance with 37 CFR § 1.56. Copies of the cited art are included with the exception of U.S. patents and published U.S. applications (1276 Off. Gaz. Pat. Off. 55, 05 August 2003). No admission is made regarding whether all the submitted references are prior art.

Respectfully submitted,

Dated: 3/26/04By: 

David G. Latwesen, Ph.D.

Reg. No. 38,533

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2466		SERIAL NO. 10756,621	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Cem Basceri et al.			
				FILING DATE January 12, 2004		PRIORITY GROUP 2831	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,558,517 B2	05-2003	Basceri			
	AB	6,511,896 B2	01-2003	Basceri et al.			
	AC	6,492,241 B1	12-2002	Rhodes et al.			
	AD	6,482,736 B1	11-2002	Basceri et al.			
	AE	6,337,237 B1	01-2002	Basceri et al.			
	AF	6,335,049 B1	01-2002	Basceri			
	AG	6,334,357 B1	03-2003	Basceri et al.			
	AH	6,476,432 B1	11-2002	Basceri et al.			
	AI	6,320,244 B1	11-2001	Ajers et al.			
	AJ	6,255,187 B1	07-2001	Horli			
	AK	6,150,226	11-2000	Reinberg			
	AL	6,387,751 B2	05-2002	Tominaga			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
	AM						
	AN						
	AO						
	AP						
	AO						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
EXAMINER				DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTQ-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2466		SERIAL NO. 10/756,621	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Cem Basceri et al.			
				FILING DATE January 12, 2004		PRIORITY GROUP 2831	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	2003/0025142 A1	02-2003	Rhodes et al.			
	AB	2003/0003621 A1	01-2003	Rhodes et al.			
	AC	2003/0017266 A1	01-2003	Basceri et al.			
	AD	2003/0043006 A1	03-2003	Basceri			
	AE	2003/0017265 A1	01-2003	Basceri et al.			
	AF	2002/0115232 A1	08-2002	Haukka et al.			
	AG	2003/0168750 A1	09-2003	Basceri et al.			
	AH	2003/0168689 A1	09-2003	Basceri et al.			
	AI	2003/0129799 A1	07-2003	Nam et al.			
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
	AM						
	AN						
	AO						
	AP						
	AQ						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
	AT						
EXAMINER				DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							